

**Search Notes**

Application/Control No.

10/020,285

Examiner

Erin M. File

Applicant(s)/Patent under  
Reexamination

WON-SUK HEO

Art Unit

2634

**SEARCHED**

Class	Subclass	Date	Examiner
375	260	6/5/2005	EMF
375	272-280	6/5/2005	EMF
375	285	6/5/2005	EMF
375	343	6/5/2005	EMF
375	367	6/5/2005	EMF
327	164	6/5/2005	EMF
370	203	6/5/2005	EMF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	6/5/2005	EMF
PALM INVENTORSHIP	6/5/2005	EMF
IEEE Keyword Search	6/5/2005	EMF